

International workshop on non-invasive beam profile monitors for hadron machines and its related techniques: 3rd IPM workshop

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Type: **not specified**

**J-PARC Primary Beamline Beam Induced
Fluorescence Profile Monitor R&D**

Wednesday, 19 September 2018 10:00 (30 minutes)

Presenter: Dr FRIEND, Megan (KEK)

Session Classification: Beam Induced Fluorescence Monitors and the other monitors